

Search Notes

Application/Control No.

09/819,555

Examiner

John L. Shew

Applicant(s)/Patent under
Reexamination

CHIU ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	229-230	7/11/2005	JS
	230.1		
	231-235		
	235.1-236		
	236.1		
	236.2		
	237		
	238		
	238.1		
	239,240		
	242,328		
	238.1		
	239-240		
	242		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	237	7/11/2005	JS
379	221.03	7/11/2005	JS
709	242	7/11/2005	JS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

Search Notes (continued)

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SEARCHED

Class	Subclass	Date	Examiner
370	328	7/11/2005	JS
	351-352		
	395.4		
	401,522		
379	219	7/11/2005	JS
	221.03		
	221.04		
709	239-242	7/11/2005	JS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

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(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR